# MOSFET – Power, Single, N-Channel, SO-8 FL 30 V, 79 A

## **Features**

- Low R<sub>DS(on)</sub>, Low Capacitance and Optimized Gate Charge to Minimize Conduction, Driver and Switching Losses
- Next Generation Enhanced Body Diode, Engineered for Soft Recovery, Provides Schottky–Like Performance
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

## **Applications**

- CPU Power Delivery
- DC-DC Converters

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

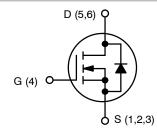
Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	30	V
Gate-to-Source Volta	age		$V_{GS}$	±20	V
Continuous Drain Current R <sub>0JA</sub> (Note 1)		$T_A = 25^{\circ}C$ $T_A = 100^{\circ}C$	Ι <sub>D</sub>	19.5 12.3	Α
Power Dissipation R <sub>0JA</sub> (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.62	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	35	Α
Current R <sub>θJA</sub> ≤ 10 s (Note 1)		T <sub>A</sub> = 100°C		22	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T <sub>A</sub> = 25°C	$P_{D}$	8.4	W
Continuous Drain	State	T <sub>A</sub> = 25°C	I <sub>D</sub>	11.6	Α
Current R <sub>0JA</sub> (Note 2)		T <sub>A</sub> = 100°C		7.3	
Power Dissipation $R_{\theta JA}$ (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.92	W
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	79	Α
Current R <sub>θJC</sub> (Note 1)		T <sub>C</sub> =100°C		50	
Power Dissipation R <sub>0</sub> JC (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	43	W
Pulsed DrainCurrent	Pulsed DrainCurrent $T_A = 25^{\circ}C$ , $t_p = 10 \mu s$		I <sub>DM</sub>	235	Α
Current Limited by Package T <sub>A</sub> = 25°C			I <sub>Dmax</sub>	100	Α
Operating Junction ar Temperature	Operating Junction and Storage Temperature		T <sub>J</sub> , T <sub>STG</sub>	–55 to +150	°C
Source Current (Body Diode)		I <sub>S</sub>	39.2	Α	
Drain to Source DV/DT			dV/d <sub>t</sub>	6.0	V/ns



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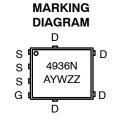
V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
30 V	3.8 m $\Omega$ @ 10 V	79 A
	4.8 mΩ @ 4.5 V	137



**N-CHANNEL MOSFET** 



STYLE 1



4936N = Specific Device Code A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

## **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMFS4936NT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NTMFS4936NT3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel
NTMFS4936NCT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NTMFS4936NCT3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter	Symbol	Value	Unit
Single Pulse Drain-to-Source Avalanche Energy ( $T_J$ = 25°C, $V_{DD}$ = 50 V, $V_{GS}$ = 10 V, $I_L$ = 44 $A_{pk}$ , $L$ = 0.1 mH, $R_G$ = 25 $\Omega$ )	E <sub>AS</sub>	96.8	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	TL	260	ů

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	2.9	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	47.7	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	135.2	*C/VV
Junction-to-Ambient – (t ≤ 10 s) (Note 3)	$R_{ heta JA}$	14.8	

- 3. Surface–mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 4. Surface-mounted on FR4 board using the minimum recommended pad size.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> =	250 μΑ	30			V
Drain-to-Source Breakdown Voltage (transient)	V <sub>(BR)DSSt</sub>	VGS = 0 V, I <sub>D(aval)</sub> = 18.5 A, T <sub>case</sub> = 25°C, t <sub>transient</sub> = 100 ns		34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				15		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$				±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \mu A$		1.2	1.6	2.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V I <sub>D</sub> = 30 A			2.9	3.8	
			I <sub>D</sub> = 15 A		2.9		0
	$V_{GS} = 4.5 \text{ V}$ $I_D =$		I <sub>D</sub> = 30 A		3.9	4.8	mΩ
			I <sub>D</sub> = 15 A		3.9		1
Forward Transconductance	9FS	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A			50		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 15 V			3044		
Output Capacitance	C <sub>OSS</sub>				1014		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				39		1
Capacitance Ratio	C <sub>RSS</sub> / C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 15 V, f = 1 MHz			0.013	0.026	

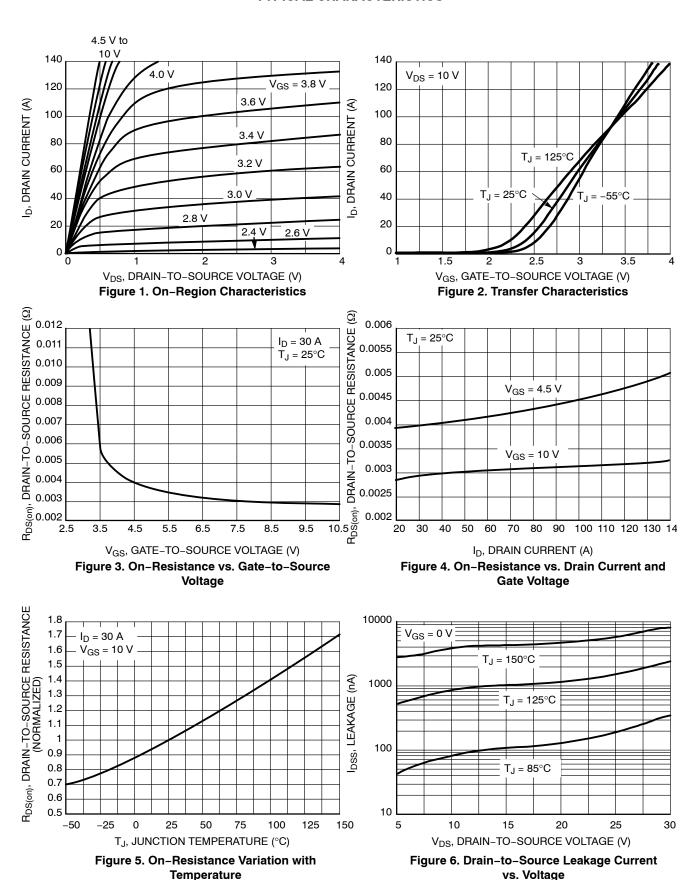
- 5. Pulse Test: pulse width  $\leq$  300  $\mu\text{s},$  duty cycle  $\leq$  2%.
- 6. Switching characteristics are independent of operating junction temperatures.

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

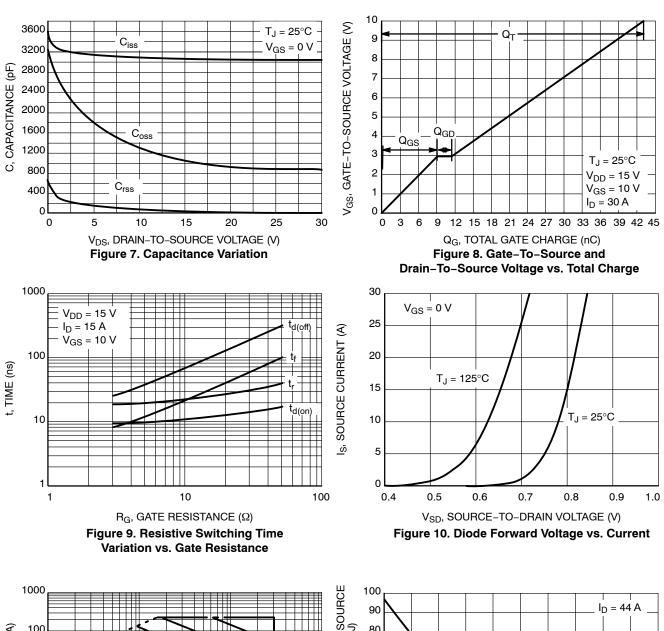
Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
CHARGES, CAPACITANCES & GATE	RESISTANCE				•	•	-
Total Gate Charge	$Q_{G(TOT)}$				19		
Threshold Gate Charge	Q <sub>G(TH)</sub>	1,,,	5./ L 00.4		4.6		nC
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 1$	5 V; I <sub>D</sub> = 30 A		9.2		
Gate-to-Drain Charge	$Q_{GD}$				2.4		1
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 1	5 V; I <sub>D</sub> = 30 A		43		nC
SWITCHING CHARACTERISTICS (No	ote 6)						
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			15.5		ns
Rise Time	t <sub>r</sub>				20.6		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				24.6		
Fall Time	t <sub>f</sub>				7.0		
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$			10.4		ns
Rise Time	t <sub>r</sub>				19		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				29		
Fall Time	t <sub>f</sub>				8.0		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.8	1.1	V
		I <sub>S</sub> = 30 A	T <sub>J</sub> = 125°C		0.65		ľ
Reverse Recovery Time	t <sub>RR</sub>				39		
Charge Time	t <sub>a</sub>	V <sub>GS</sub> = 0 V, dIS/dt =	= 100 A/μs,		21.5		ns
Discharge Time	t <sub>b</sub>	I <sub>S</sub> = 30 /	I <sub>S</sub> = 30 A		17.5		
Reverse Recovery Charge	Q <sub>RR</sub>	]			36		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>				0.65		nH
Drain Inductance	L <sub>D</sub>	T <sub>A</sub> = 25°C			0.005		nH
Gate Inductance	L <sub>G</sub>				1.84		nH
Gate Resistance	$R_{G}$				1.1	2.0	Ω

<sup>5.</sup> Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

## **TYPICAL CHARACTERISTICS**



## **TYPICAL CHARACTERISTICS**



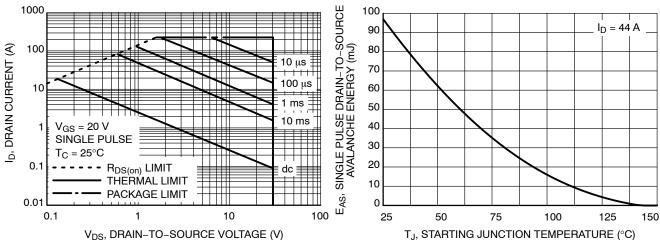


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

## **TYPICAL CHARACTERISTICS**

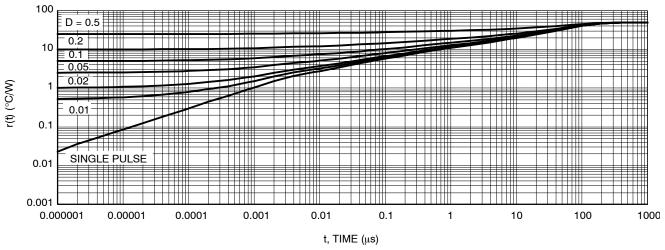
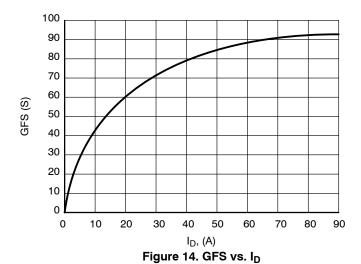


Figure 13. Thermal Response



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0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

**DATE 25 JUN 2018** 

#### NOTES:

BURRS

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETER.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е		1.27 BSC			
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
М	3.00	3.40	3.80		
θ	0 °		12 °		

## **GENERIC** MARKING DIAGRAM\*



XXXXXX = Specific Device Code

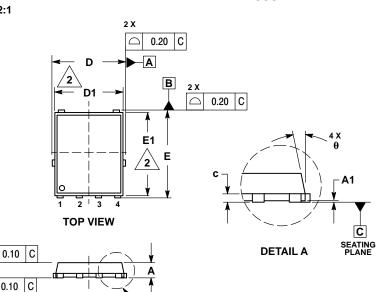
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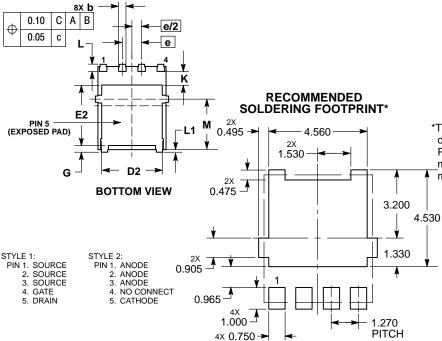
= Assembly Location Α

Υ = Year W = Work Week

ZZ

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





**DETAIL A** 

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

**DIMENSIONS: MILLIMETERS** 

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